STL18N65M5



N-channel 650 V, 0.215 Ω typ., 15 A MDmesh™ V Power MOSFET in a PowerFLAT™ 5x6 HV package

Datasheet - preliminary data

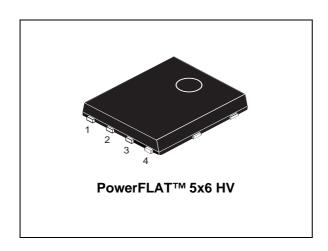
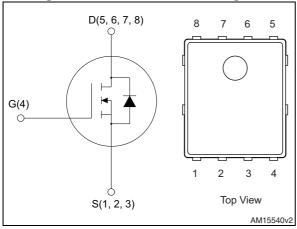


Figure 1. Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)max} .	I _D
STL18N65M5	710 V	0.240 Ω	15 A ⁽¹⁾

- The value is rated according to R_{thj-case} and limited by package.
- Outstanding R_{DS(on)}*area
- Extremely large avalanche performance
- Gate charge minimized
- Very low intrinsic capacitance
- 100% avalanche tested

Applications

• Switching applications

Description

This device is an N-channel MDmesh™ V Power MOSFET based on an innovative proprietary vertical process technology, which is combined with STMicroelectronics' well-known PowerMESH™ horizontal layout structure. The resulting product has extremely low onresistance, which is unmatched among siliconbased Power MOSFETs, making it especially suitable for applications which require superior power density and outstanding efficiency.

Table 1. Device summary

Order code	Marking	Package	Packaging
STL18N65M5	18N65M5	PowerFLAT™ 5x6 HV	Tape and reel

Contents STL18N65M5

Contents

1	Electrical ratings	3
2	Electrical characteristics	
3	Test circuits	
4	Package mechanical data	10
5	Packaging mechanical data	14
6	Revision history	16

STL18N65M5 Electrical ratings

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 25	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25 °C	15	Α
I _D ⁽¹⁾	Drain current (continuous) at T _C = 100 °C	6.5	Α
I _{DM} (1),(2)	Drain current (pulsed)	60	Α
P _{TOT} ⁽¹⁾	Total dissipation at T _C = 25 °C	57	W
I _{AR}	Avalanche current, repetitive or not- repetitive (pulse width limited by T _j max)	4	А
E _{AS}	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$, $V_{DD} = 50$ V)	210	mJ
dv/dt (3)	Peak diode recovery voltage slope	15	V/ns
T _{stg}	Storage temperature	- 55 to 150	°C
Tj	Max. operating junction temperature	150	°C

^{1.} The value is rated according to $R_{\mbox{\scriptsize thj-case}}$ and limited by package.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	2.2	°C/W
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-amb max	59	°C/W

^{1.} When mounted on 1inch² FR-4 board, 2 oz Cu.

^{2.} Pulse width limited by safe operating area.

^{3.} $I_{SD} \leq$ 15 A, di/dt \leq 400 A/ μ s, $V_{Peak} \leq V_{(BR)DSS}$, V_{DD} = 400 V.

Electrical characteristics STL18N65M5

2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage (V _{GS} = 0)	I _D = 1 mA	650			V
I _{DSS}	_	V _{DS} = 650 V V _{DS} = 650 V, T _C =125 °C			1 100	μA μA
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			± 100	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	$V_{GS} = 10 \text{ V}, I_D = 7.5 \text{ A}$		0.215	0.240	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	1240	-	pF
C _{oss}	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	32	-	pF
C _{rss}	Reverse transfer capacitance	$V_{GS} = 0$	-	3	-	pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related		-	99	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	$V_{DS} = 0$ to 520 V, $V_{GS} = 0$	-	30	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz open drain	-	3	-	Ω
Qg	Total gate charge	V _{DD} = 520 V, I _D = 7.5 A,	-	31	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	8	-	nC
Q _{gd}	Gate-drain charge	(see Figure 16)	-	14	-	nC

^{1.} $C_{oss\,eq}$ time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

^{2.} $C_{oss\ eq.}$ energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	36	-	ns
t _r	Rise time	$V_{DD} = 400 \text{ V}, I_D = 9.5 \text{ A},$	-	7	-	ns
t _{d(off)}	Turn-off delay time	$R_G = 4.7 \Omega, V_{GS} = 10 V$ (see <i>Figure 17</i> and <i>20</i>)	-	9	-	ns
t _f	Fall time		-	11	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} ⁽¹⁾	Source-drain current		-		15	Α
I _{SDM} (1),(2)	Source-drain current (pulsed)		-		60	Α
V _{SD} (3)	Forward on voltage $I_{SD} = 15 \text{ A}, V_{GS} = 0$		-		1.5	V
t _{rr}	Reverse recovery time	45 4 41/44 400 4/4-	-	290		ns
Q_{rr}	Reverse recovery charge	I _{SD} = 15 A, di/dt = 100 A/μs V _{DD} = 60 V (see <i>Figure 17</i>)	-	3.4		μC
I _{RRM}	Reverse recovery current	TOD SET (SEE TIGHTS TIT)	-	23.5		Α
t _{rr}	Reverse recovery time	I _{SD} = 15 A, di/dt = 100 A/μs	-	352		ns
Q _{rr}	Reverse recovery charge	$V_{DD} = 60 \text{ V}, T_j = 150 ^{\circ}\text{C}$	-	4		μC
I _{RRM}	Reverse recovery current	(see Figure 17)	-	24		Α

^{1.} The value is rated according to $R_{\mbox{\scriptsize thj-case}}$ and limited by package.

^{2.} Pulse width limited by safe operating area

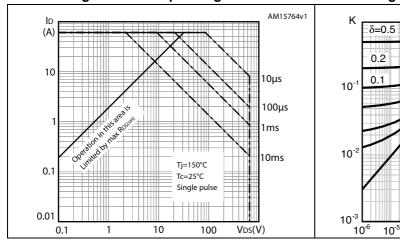
^{3.} Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

Electrical characteristics STL18N65M5

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

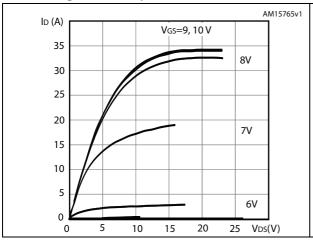
Figure 3. Thermal impedance



K δ =0.5 0.2 0.2 0.1 0.05 0.02 0.01 0.01 0.05 0.02 0.01 0.01 0.05

Figure 4. Output characteristics

Figure 5. Transfer characteristics



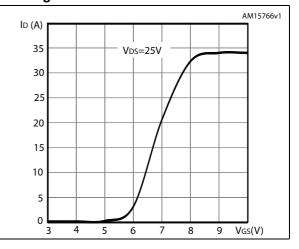
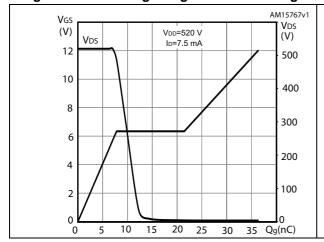


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on-resistance



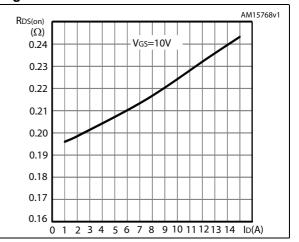


Figure 8. Capacitance variations

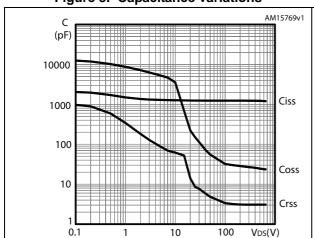


Figure 9. Output capacitance stored energy

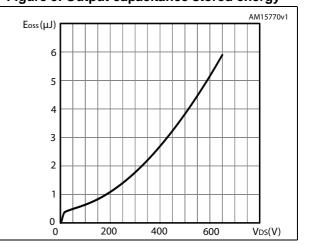
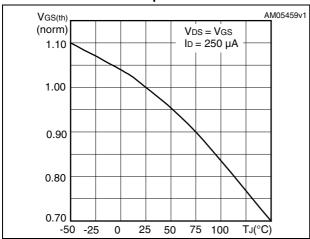


Figure 10. Normalized gate threshold voltage vs. temperature

Figure 11. Normalized on-resistance vs. temperature



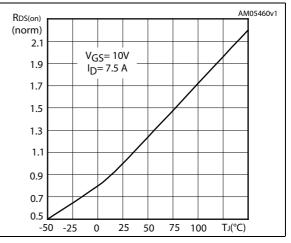
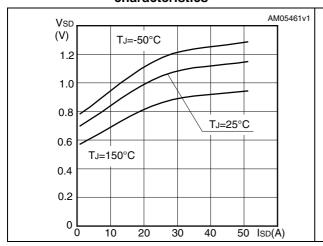
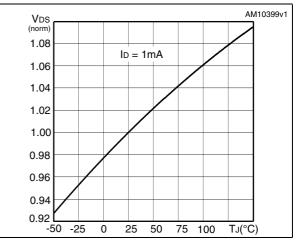


Figure 12. Drain-source diode forward characteristics

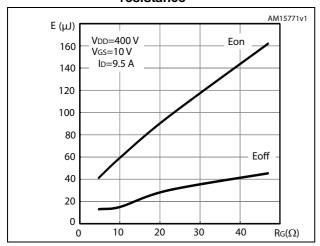
Figure 13. Normalized B_{VDSS} vs. temperature





Electrical characteristics STL18N65M5

Figure 14. Switching losses vs gate resistance ⁽¹⁾



1. Eon including reverse recovery of a SiC diode

STL18N65M5 Test circuits

3 Test circuits

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

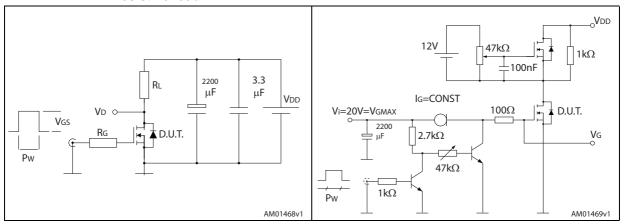


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped inductive load test circuit

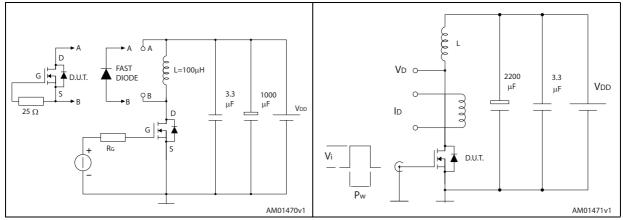
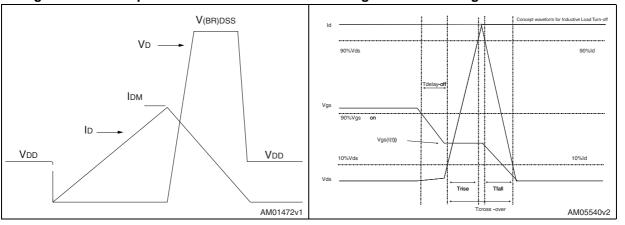


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.

10/17 DocID023634 Rev 2

Table 8. PowerFLAT™ 5x6 HV creepage

Dim.		mm	
Dim.	Min.	Тур.	Max.
А	0.80		1.00
A1	0.02		0.05
A2		0.25	
b	0.30		0.50
D	5.00	5.20	5.40
E	5.95	6.15	6.35
D2	4.30	4.40	4.50
E2	3.10	3.20	3.30
е		1.27	
L	0.50	0.55	0.60
К	1.90	2.00	2.10
aaa		0.15	
bbb		0.15	
ccc		0.10	
eee		0.10	

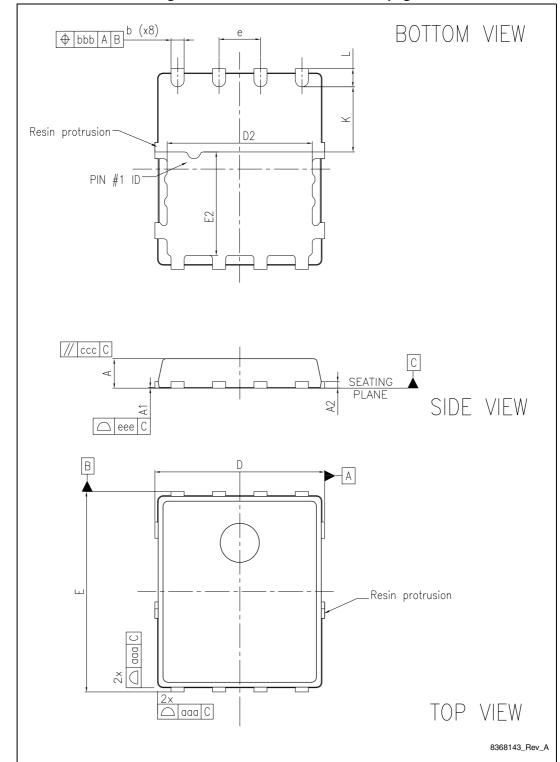


Figure 21. PowerFLAT™ 5x6 HV creepage

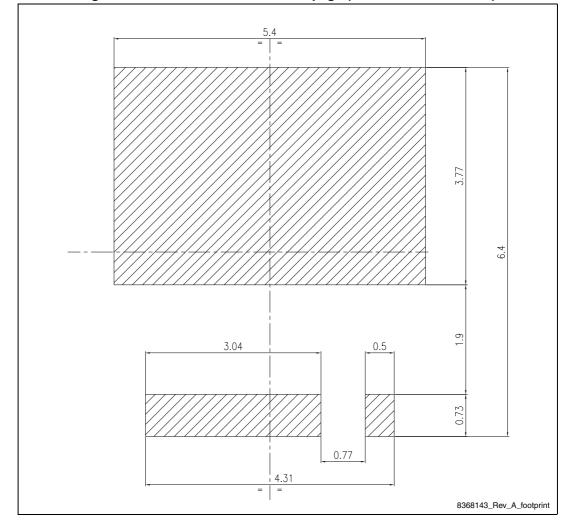


Figure 22. PowerFLAT™ 5x6 HV creepage (dimensions are in mm)

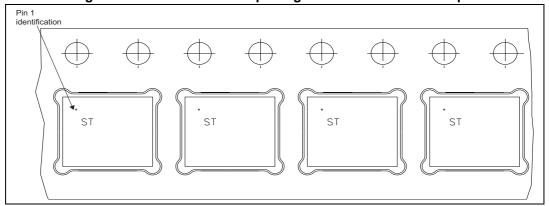
8234350_Tape_rev_C

Packaging mechanical data 5

P₀ 4.0±0.1 (II) T (0.30±0.05) E₁ -- 1.75±0.1 Do Ø1.55±0.05 F(5.50±0.1)(III) P1(8.00±0.1) Ko (1.20±0.1) SECTION Y-Y (I) Measured from centerline of sprocket hole to centerline of pocket. Base and bulk quantity 3000 pcs (II) Cumulative tolerance of 10 sprocket holes is $\pm\ 0.20$. (III) Measured from centerline of sprocket hole to centerline of pocket.

Figure 23. PowerFLAT™ 5x6 tape

Figure 24. PowerFLAT™ 5x6 package orientation in carrier tape.



DocID023634 Rev 2 14/17

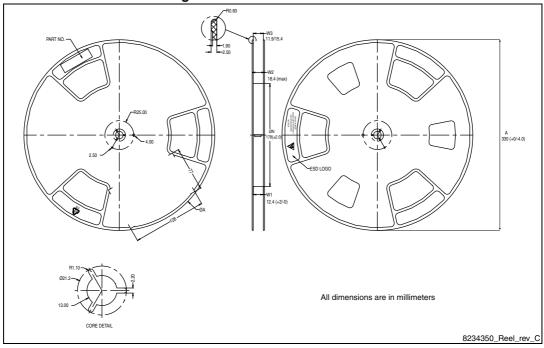


Figure 25. PowerFLAT™ 5x6 reel

Revision history STL18N65M5

6 Revision history

Table 9. Document revision history

Date	Revision	Changes
24-Apr-2013	1	First release
26-Jun-2013	2	Modified: Figure 6, 15, 16, 17, 18Minor text changes

Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

ST PRODUCTS ARE NOT AUTHORIZED FOR USE IN WEAPONS. NOR ARE ST PRODUCTS DESIGNED OR AUTHORIZED FOR USE IN: (A) SAFETY CRITICAL APPLICATIONS SUCH AS LIFE SUPPORTING, ACTIVE IMPLANTED DEVICES OR SYSTEMS WITH PRODUCT FUNCTIONAL SAFETY REQUIREMENTS; (B) AERONAUTIC APPLICATIONS; (C) AUTOMOTIVE APPLICATIONS OR ENVIRONMENTS, AND/OR (D) AEROSPACE APPLICATIONS OR ENVIRONMENTS. WHERE ST PRODUCTS ARE NOT DESIGNED FOR SUCH USE, THE PURCHASER SHALL USE PRODUCTS AT PURCHASER'S SOLE RISK, EVEN IF ST HAS BEEN INFORMED IN WRITING OF SUCH USAGE, UNLESS A PRODUCT IS EXPRESSLY DESIGNATED BY ST AS BEING INTENDED FOR "AUTOMOTIVE, AUTOMOTIVE SAFETY OR MEDICAL" INDUSTRY DOMAINS ACCORDING TO ST PRODUCT DESIGN SPECIFICATIONS. PRODUCTS FORMALLY ESCC, QML OR JAN QUALIFIED ARE DEEMED SUITABLE FOR USE IN AEROSPACE BY THE CORRESPONDING GOVERNMENTAL AGENCY.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2013 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Philippines - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com



Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

STMicroelectronics: STL18N65M5